

<b>Notice of References Cited</b>	Application/Control No. 10/825,108		Applicant(s)/Patent Under Reexamination MATSUMOTO ET AL.	
	Examiner Santanu Chatterjee		Art Unit 3661	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,487,501 B1	11-2002	Jeon, Yong-Won	701/301
*	B	US-6,489,887 B2	12-2002	Satoh et al.	340/436
*	C	US-6,411,901 B1	06-2002	Hiwatashi et al.	701/301
*	D	US-6,057,754	05-2000	Kinoshita et al.	340/435
*	E	US-6,216,079 B1	04-2001	Matsuda, Shohei	701/70
*	F	US-2002/0013647 A1	01-2002	Kawazoe et al.	701/41
*	G	US-6,021,367	02-2000	Pilutti et al.	701/41
*	H	US-6,059,067	05-2000	Shibahata et al.	180/338
*	I	US-6,334,656 B1	01-2002	Furukawa et al.	303/146
*	J	US-2003/0014162 A1	01-2003	Sadano, On	701/1
*	K	US-4,727,492	02-1988	Reeve et al.	701/25
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.